## Notice of References Cited Application/Control No. 10/055,455 Examiner Raymond J. Bayerl U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination LANE, DEREK GRAHAM Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,835,085	11-1998	Eick et al.	715/853
	В	US-6,437,799	08-2002	Shinomi, Hideaki	715/853X
	С	US-6,486,898	11-2002	Martino et al.	715/853
	D	US-6,509,898	01-2003	Chi et al.	345/440
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R					
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.